

Notice of References Cited	Application/Control No. 10/531,223		Applicant(s)/Patent Under Reexamination RYDGREN ET AL.	
	Examiner Naghmeh Mehrpour		Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0130593	06-2005	Michalak, Gerald P.	455/066.1
*	B	US-2003/0040344	02-2003	Shteyn et al.	455/573
*	C	US-2004/0198470	10-2004	Dyer et al.	455/575.1
*	D	US-2004/0242264	12-2004	Cho, Sung-Woo	455/550.1
*	E	US-2005/0272477	12-2005	Boykins et al.	455/569.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.